### 16.216: ECE Application Programming

## Practice Problems for Exam 2

Note that these problems do not cover all material to be tested on the second exam. However, any topic that is not covered by at least one practice problem will only be tested in a multiple choice question (if at all).

1. Assume the state of the 80386DX's registers and memory are:

- $(E A X)=00005555 \mathrm{H}$
- (DS:111H) $=\mathrm{FFH}$
- $(E B X)=00000010 \mathrm{H}$
- $(\mathrm{DS:200H})=30 \mathrm{H}$
- $(E C X)=00000010 \mathrm{H}$
- $(\mathrm{DS}: 201 \mathrm{H})=00 \mathrm{H}$
- $(E D X)=0000 A A A A H$
- $(\mathrm{DS}: 210 \mathrm{H})=\mathrm{AAH}$
- $(E S I)=00000100 \mathrm{H}$
- $(\mathrm{DS}: 211 \mathrm{H})=\mathrm{AAH}$
- $\quad(E D I)=00000200 \mathrm{H}$
- $(\mathrm{DS}: 220 \mathrm{H})=55 \mathrm{H}$
- $(\mathrm{DS:} 100 \mathrm{H})=0 \mathrm{FH}$
- $(\mathrm{DS}: 221 \mathrm{H})=55 \mathrm{H}$
- $(\mathrm{DS}: 101 \mathrm{H})=\mathrm{F} 0 \mathrm{H}$
- $(\mathrm{DS}: 300 \mathrm{H})=\mathrm{AAH}$
- $(\mathrm{DS}: 110 \mathrm{H})=00 \mathrm{H}$
- $(\mathrm{DS}: 301 \mathrm{H})=55 \mathrm{H}$

Also, assume all flags (ZF, CF, SF, PF, OF) are initialized to 0 .
For each instruction sequence shown below, list all changed registers and/or memory locations and their new values, as well as all changed flags from the list above. Note that the registers and memory have the same starting values at the beginning of each sequence, but a value changed by one instruction in a sequence can affect the results of all other instructions in the same sequence.
a. BT AX, 4

SETC [100H]
BTS AX, 5
SETC [101H]
BTR AX, 6
SETC [110H]
BTC AX, 7
SETC [111H]
b. BSF AL, WORD PTR [BX+SI]

BSR AH, WORD PTR [BX+SI]
CMP AL, AH
JG S
MOV DX, [200H]
JMP E
S: MOV DX, [210H]
E: MOV [BX+DI+10H],DX

1 (cont.) Assume the state of the 80386DX's registers and memory are:

- $(E A X)=00005555 \mathrm{H}$
- $(E B X)=00000010 \mathrm{H}$
- $(E C X)=00000010 \mathrm{H}$
- $(E D X)=0000 A A A A H$
- $(E S I)=00000100 \mathrm{H}$
- $(E D I)=00000200 \mathrm{H}$
- $(\mathrm{DS:} 100 \mathrm{H})=0 \mathrm{FH}$
- $(\mathrm{DS}: 101 \mathrm{H})=\mathrm{F} 0 \mathrm{H}$
- $(\mathrm{DS}: 110 \mathrm{H})=00 \mathrm{H}$
- $(\mathrm{DS}: 111 \mathrm{H})=\mathrm{FFH}$
- $(\mathrm{DS}: 200 \mathrm{H})=30 \mathrm{H}$
- $(\mathrm{DS}: 201 \mathrm{H})=00 \mathrm{H}$
- $(\mathrm{DS}: 210 \mathrm{H})=\mathrm{AAH}$
- $(\mathrm{DS}: 211 \mathrm{H})=\mathrm{AAH}$
- $(\mathrm{DS}: 220 \mathrm{H})=55 \mathrm{H}$
- $(\mathrm{DS}: 221 \mathrm{H})=55 \mathrm{H}$
- $(\mathrm{DS}: 300 \mathrm{H})=\mathrm{AAH}$
- $(\mathrm{DS}: 301 \mathrm{H})=55 \mathrm{H}$

Also, assume all flags (ZF, CF, SF, PF, OF) are initialized to 0 .

| c. | CMP | AL, | 56H |
| :---: | :---: | :---: | :---: |
|  | JL | L1 |  |
|  | JG | L2 |  |
|  | MOV | AH, | BL |
|  | JMP | E |  |
| L1: | MOV | AH, | CH |
|  | JMP | E |  |
| L2: | MOV | AH, | DL |
| E: | SETL | [DI] |  |
| d. | MOV | AX, | 0001H |
|  | MOV | CX, | 0004H |
| ST: | SHL | AX, | CX |
|  | LOOP | ST |  |
| e.ST: | MOV | AX, | 8000H |
|  | SAR | AX, | 1 |
|  | CMP | AX, | [BX+SI] |
|  | LOOPN | NE ST |  |

2. As noted in class, the SETcc instruction can be used to combine multiple conditions together to create a compound conditional test. For example, the code below tests the condition $((A<B) \& \&(C<D))$, storing the result in DL:

| MOV | $A X$, | A |
| :--- | :--- | :--- |
| CMP | AX, | B |

SETL DL
MOV AX, C
CMP AX, D
SETL DH
AND DL, DH
For each part of this problem, assume A, B, C, D, E, and F refer to signed integers stored in memory.
a. What compound condition is tested by each of the code sequences below?

| i. | MOV | AX, | A | iii. MOV | AX, |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | CMP | AX, | B | SUB | AX, | B |
|  | SETLE | BL |  | CMP | AX, | C |
|  | CMP | AX, | E | SETGE | BL |  |
|  | SETGE | BH |  | MOV | AX, | D |
|  | OR | BL, | BH | ADD | AX, | E |
|  |  |  |  | SUB | AX, | F |
| ii. | MOV | AX, | C | SETNZ | BH |  |
|  | CMP | AX, | A | OR | BL, | BH |
|  | SETE | BL |  |  |  |  |
|  | MOV | AX, | B |  |  |  |
|  | CMP | AX, | A |  |  |  |
|  | SETNE | BH |  |  |  |  |
|  | AND | BL, | BH |  |  |  |
|  | CMP | AX, | C |  |  |  |
|  | SETL | BH |  |  |  |  |
|  | AND | BL, | BH |  |  |  |
|  | CMP | AX, | A |  |  |  |
|  | SETZ | BH |  |  |  |  |
|  | OR | BL, | BH |  |  |  |

b. Write a sequence of instructions that tests each of the following compound conditions.
i. $\quad((A>B)|\mid(A<C)) \& \&((A \quad!=D)|\mid(A==E))$
ii. $\quad((A-B>0) \& \&!C)$
iii. $\quad((B>=A+C)|\mid(D<=C+A))$
3. Assume $\mathrm{CS}=1010 \mathrm{H}, \mathrm{IP}=1 \mathrm{~A} 00$, and $\mathrm{EBX}=20 \mathrm{AAFE} 00$. What is the starting address of each subroutine accessed by the CALL instructions below? (In other words, what is the target address of the CALL?)
i. CALL 0100 H
ii. CALL FFFOH
iii. CALL 411ABE00
iv. CALL BX
v. CALL EBX
4. Assume the 80386 is running in protected mode with the state given below (all values in hex); note that each memory location shown contains a descriptor about a particular segment:

GDTR $=00200000001 \mathrm{~F}$
LDTR $=000 \mathrm{~B}$

DS $=0017$
SS = 0018
ESI $=00001000$
EBX $=0001120$
Memory

| Base $=030010 F 0$ <br> Limit $=020 F$ | Address |
| :--- | :--- |
| Base $=00200020$ <br> Limit $=0017$ | 00200000 |
| Base $=00200038$ <br> Limit $=0010$ | 002000008 |
| Base $=1200 C 000$ <br> Limit $=$ FFFF | 00200010 |
| Base $=12340000$ <br> Limit $=00 F F$ | 00200020 |

a. What is the base address and limit of the global descriptor table? How many descriptors does this table contain?
b. What is the base address and limit of the current local descriptor table? How many descriptors does this table contain?
c. What are the starting and ending addresses for the current data and stack segments?
d. What address is accessed by each of the following instructions?

| i. | MOV | $A X,[0100 H]$ |
| ---: | :--- | :--- |
| ii. | ADD | $D X,[S I]$ |
| iii. | MOV | $A X, S S:[S I+E F 00]$ |
| iv. | SUB | SS: $[A 200], C X$ |
| v. | MOV | $D X,[B X+S I]$ |
| vi. | MOV | $C X,[B X+S I+1 E H]$ |

